

Application No.	Applicant(s)						
10/615,210	FRANCO ET AL.						
Examiner	Art Unit						
Saeed T Chaudhry	1746						

ISSUE CLASSIFICATION													
ORIGINAL		CE(S)											
CLASS SUBCLASS	CLASS	CLASS   SUBCLASS (ONE SUBCLASS PER BLOCK)											
15 250.02	15	250.01 250.05											
INTERNATIONAL CLASSIFICATION	239	284.1	135	5 1	28								
B 6 0 S 1/02													
7													
David Chaudhry	12.21:04	MONAEL BADD								4.4			
		MICHAEL BARR Total Claims All SUPERVISORY PATENT EXAMINER							SAIIC	weu.			
(Assistant Examiner) (Dat	(e) احرا د ر ا	✓n.	15.					O.G.		Ιo	G.		
1 4 Day 1.8	אוווו	אאנא	ت ک	<b>&gt;</b>	12/2	:Y07 }		Print Claim(	s):::::::::		t Fig.		
(Legal Instruments Ayamijler)	(Dete)		нагу Еха	miner)	(Date	)					2		
								•					
◯ Claims renumbered in the	same order	as presen	ted by	applicant	t 🗆 c	PA				□R	.1.47		
		а		<u>a</u>		<u>a</u>		_ at			<u>a</u>		
Final Original Original	Final	Original	Final	Original	Final	Original		Final Original		Final	Original		
	"	ŏ	"	ōΙ	"	Ŏ	1	۳   ō		Ш	ō		
1 31		61		91		121		151			181		
2 32		62		92		122		152			182		
3 33 34		63 64	-	93		123	-	153			183		
5 35		65		94		124 125		154 155			184 185		
6 36		66		96		126		156			186		
7 37		67		97		127		157			187		
8 38		68		98		128		158			188		
9 39 40		69 70		99 100		129 130		159 160			189 190		
11 41		71		101		131		161			191		
12 42		72		102		132		162			192		
13 43		73		103		133		163			193		
14 44		74	$\overline{}$	104		134	<u> </u>	164			194		
15 45 16 46		75 76		105 106	-	135 136	-	165 166			195 196		
17 47		77		107		137	-	167			197		
18 48		78		108		138		168			198		
19 49		79		109		139		169			199		
20 50 51		80 81		110		140		170			200		
22 52		82		111 112		141 142	-	171 172			201		
23 53		83		113		143	-	173			203		
24 54		84		114		144		174			204		
25 55		85		115		145		175	[		205		
26 56 57 57		86 87		116 117	-	146 147	<u> </u>	176 177			206 207		
28 58		88		117		147	$\vdash$	177			208		
29 1 59		89		119		149		179			209		
30 2 60		90		120		150		180	Ì		210		